

<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>	
	10/612,961	NG ET AL.	
	<b>Examiner</b> Jared I. Rutz	<b>Art Unit</b> 2187	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Inventor search in PALM	8/3/2005	JIR
711/157,149; text limited, see search history	8/3/2005	JIR
text search in EAST	8/3/2005	JIR

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner